

**Search Notes****Application/Control No.**

10/561,894

**Examiner**

THANH LAM

**Applicant(s)/Patent under  
Reexamination**

GRUNDL ET AL.

**Art Unit**

2834

**SEARCHED**

Class	Subclass	Date	Examiner
310	179,198, 184,201- 202,207- 208,	9/2/2008	TL
310	216-218	9/2/2008	TL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference searched		9/2/2008	TL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR